

CY62167DV30 MoBL[®]

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Product Portfolio

												Power Dissipation					
Product	Product V _{CC} Range (V)		Speed	Operating I _{CC} (mA)				Standby Isa (uA)									
Floudet				(ns)	f = 1 MHz f = f _{Max}			Standby I _{SB2} (μA)									
	Min	Тур [1]	Max		Тур [1]	Max	Тур [1]	Max	Тур [1]	Max							
CY62167DV30LL	2.2	3.0	3.6	55	2	4	15	30	2.5	22							
				70			12	25									

Pin Configurations

Figure 1. 48-ball VFBGA pinout (Top View) ^[2, 3]

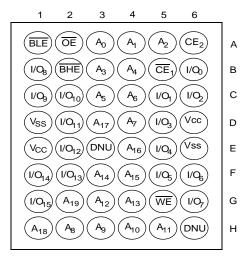


Figure 2. 48-pin TSOP I pinout (Top View)^[4]

	10
A15 = 1	48 — <u>A16</u>
A14 = 2 A13 = 3	47 BYTE
A13 3	46 🗖 Vss
A12 🗖 4	46 Vss 45 I/O15/A20
A11 🖬 5	44 🗖 1/07
A10 🖬 6	43 b 1/014
A9 🗖 7	42 🗖 1/06
A8 🗖 8	41 🗖 I/O13
A19 🖬 9	40 = 1/O5 39 = 1/O12
NC = 10 WE = 11	39 🗖 I/O12
WE 🗖 11	38 🖬 I/O4 37 🗖 Vcc
CE2 12	37 🗖 Vcc
DNU= 13	36 🗖 I/O11
BHB= 14	35 🗖 1/03
BLE = 15	34 🗖 1/010
A18 🗖 16	33 🗖 1/02
A17 🖬 17	32 🖬 1/09
A7 🗖 18	31 = 1/01
A6 🗖 19	30 🗖 1/08
A5 🗖 20	29 🗖 1/00
A4 🗖 21	28 – OE
A3 = 22	27 – <u>Vss</u>
A2 a 23	26 - CE1
A1 24	25 – A0
81 - 24	23 AU

- 1. Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at $V_{CC} = V_{CC(typ.)}$, $T_A = 25$ °C.
- 2. NC pins are not connected on the die.
- 3. DNU pins have to be left floating.
- 4. The BYTE pin the 48-TSOP I package has to be tied to V_{CC} to use the device as <u>a 1M X 16</u> SRAM. The 48-TSOP I package can also be used as a 2 M × 8 SRAM by tying the BYTE signal to V_{SS} . In the 2 M × 8 configuration, Pin 45 is A20, while BHE, BLE and I/O8 to I/O14 pins are not used (DNU).



CY62167DV30 MoBL[®]

Maximum Ratings

Exceeding maximum ratings may shorten the useful life of the device. User guidelines are not tested.

Storage temperature65 °C to +150 °C
Ambient temperature with power applied
Supply voltage to ground potential $\dots -0.2$ V to V _{CC} + 0.3 V
DC voltage applied to outputs in High-Z state $^{[5, 6]}$ 0.2 V to V _{CC} + 0.3 V
DC input voltage $^{[5,\ 6]}$ 0.2 V to V_{CC} + 0.3 V

Output current into outputs (LOW)	20 mA
Static discharge voltage	
(per MIL-STD-883, Method 3015)	> 2001 V
Latch-up current	> 200 mA

Operating Range

Device	Range	Ambient Temperature	V_{CC} ^[7]
CY62167DV30LL	Industrial	–40 °C to +85 °C	2.20 V to 3.60 V

Electrical Characteristics

Over the Operating Range

Parameter	Description	Test Co	ditiona	CY	′62167D	V30-55	CY	62167D	V30-70	Unit
Farameter	Description	Test Conditions		Min	Typ ^[8]	Max	Min	Typ ^[8]	Max	Unit
V _{OH}	Output HIGH voltage	I _{OH} = -0.1 mA	$V_{CC} = 2.20 V$	2.0	-	_	2.0	-	-	V
		I _{OH} = -1.0 mA	$V_{CC} = 2.70 V$	2.4			2.4			
V _{OL}	Output LOW voltage	l _{OL} = 0.1 mA	$V_{CC} = 2.20 V$	-	-	0.4		-	0.4	V
		I _{OL} = 2.1 mA	$V_{CC} = 2.70 V$							
V _{IH}	Input HIGH voltage	$V_{CC} = 2.2 \text{ V to } 2$	2.7 V	1.8	-	V _{CC} +0.3	1.8	-	V _{CC} +0.3	V
		$V_{\rm CC}$ = 2.7 V to 3	3.6 V	2.2			2.2			
V _{IL}	Input LOW voltage	$V_{CC} = 2.2 \text{ V to } 2$	2.7 V	-0.3	-	0.6	-0.3	-	0.6	V
		V _{CC} = 2.7 V to 3.6 V				0.8			0.8	
I _{IX}	Input leakage current	$GND \le V_I \le V_{CC}$		-1	-	+1	-1	_	+1	μΑ
I _{OZ}	Output leakage current	$GND \le V_O \le V_{CC}$, output disabled		-1	-	+1	-1	-	+1	μA
I _{CC}	V _{CC} operating supply	$V_{CC} = V_{CC(max)}$	$f = f_{Max} = 1/t_{RC}$	-	15	30	-	12	25	mA
	current		f = 1 MHz		2	4		2	4	
I _{SB1}	Automatic power-down current — CMOS inputs		/, $V_{IN} \le \overline{0.2} V$, and data only),	_	2.5	22	_	2.5	22	μA
I _{SB2}	Automatic power-down current — CMOS Inputs		V or V _{IN} ≤ 0.2V,	_	2.5	22	_	2.5	22	μA

- Notes
 5. V_{IL(min.)} = -2.0 V for pulse durations less than 20 ns.
 6. V_{IH(max)} = V_{CC} + 0.75 V for pulse durations less than 20 ns.
 7. Full Device AC operation requires linear V_{CC} ramp from 0 to V_{CC(min.)} and V_{CC} must be stable at V_{CC(min)} for 500 μs.
 8. Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at V_{CC} = V_{CC(typ)}, T_A = 25 °C.



Capacitance

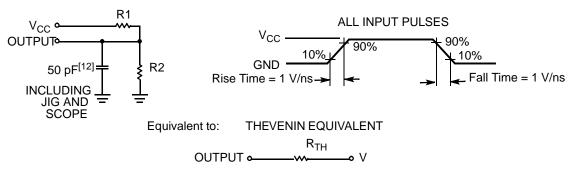
Parameter ^[10]	Description	Test Conditions	Max	Unit
C _{IN}	Input capacitance	$T_A = 25 \text{ °C}, f = 1 \text{ MHz}, V_{CC} = V_{CC(typ)}$	8	pF
C _{OUT}	Output capacitance		10	pF

Thermal Resistance

Parameter ^[10]	Description	Test Conditions	VFBGA	TSOP I	Unit
θ_{JA}		Still air, soldered on a 3 x 4.5 inch, 2-layer printed circuit board	55	60	°C/W
θ ^{JC}	Thermal resistance (junction to case)		16	4.3	°C/W

AC Test Loads and Waveforms





Parameters	2.5 V	3.0 V	Unit
R1	16667	1103	Ω
R2	15385	1554	Ω
R _{TH}	8000	645	Ω
V _{TH}	1.20	1.75	V

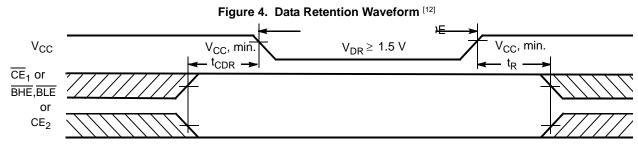


Data Retention Characteristics

Over the Operating Range

Parameter	Description	Conditions	Min	Тур ^[9]	Max	Unit
V _{DR}	V _{CC} for data retention		1.5	-	-	V
I _{CCDR}	Data retention current		-	_	10	μΑ
t _{CDR} ^[10]	Chip deselect to data retention time		0	-	-	ns
t _R ^[11]	Operation recovery time	CY62167DV30LL-55	5 55	-	-	ns
		CY62167DV30LL-70) 70			

Data Retention Waveform



- 9. Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at $V_{CC} = V_{CC(typ)}$, $T_A = 25$ °C. 10. Tested initially and after any design or process changes that may affect these parameters. 11. <u>Full device</u> operation requires <u>linear</u> V_{CC} ramp from V_{DR} to V_{CC(min.)} \geq 100 µs or stable at V_{CC(min.)} \geq 100 µs. 12. <u>BHE.BLE</u> is the AND of both <u>BHE</u> and <u>BLE</u>. Chip can be deselected by either disabling the chip enable signals or by disabling both <u>BHE</u> and <u>BLE</u>.



Switching Characteristics

Over the Operating Range

Parameter [13]	Description	55	ns	70 ns		Unit
Parameter	Description	Min	Max	Min	Max	Onit
Read Cycle					•	
t _{RC}	Read cycle time	55	-	70	-	ns
t _{AA}	Address to data valid	-	55	-	70	ns
t _{OHA}	Data hold from address change	10	-	10	-	ns
t _{ACE}	CE ₁ LOW and CE ₂ HIGH to data valid	-	55	_	70	ns
t _{DOE}	OE LOW to data valid	-	25	-	35	ns
t _{LZOE}	OE LOW to low Z ^[14]	5	-	5	-	ns
t _{HZOE}	OE HIGH to high Z ^[14, 15]	-	20	-	25	ns
t _{LZCE}	CE ₁ LOW and CE ₂ HIGH to low Z ^[14]	10	-	10	-	ns
t _{HZCE}	CE ₁ HIGH and CE ₂ LOW to high Z ^[14, 15]	_	20	-	25	ns
t _{PU}	CE ₁ LOW and CE ₂ HIGH to power-up	0	-	0	-	ns
t _{PD}	CE ₁ HIGH and CE ₂ LOW to power-down	-	55	-	70	ns
t _{DBE}	BLE/BHE LOW to data valid	_	55	-	70	ns
t _{LZBE}	BLE/BHE LOW to low Z ^[14]	10	-	10	-	ns
t _{HZBE}	BLE/BHE HIGH to high Z ^[14, 15]	_	20	-	25	ns
Write Cycle [16	j				•	
t _{WC}	Write cycle time	55	-	70	-	ns
t _{SCE}	CE ₁ LOW and CE ₂ HIGH to write end	40	-	60	-	ns
t _{AW}	Address setup to write end	40	-	60	-	ns
t _{HA}	Address hold from write end	0	-	0	-	ns
t _{SA}	Address setup to write start	0	-	0	-	ns
t _{PWE}	WE pulse width	40	-	45	-	ns
t _{BW}	BLE/BHE LOW to write end	40	-	60	-	ns
t _{SD}	Data setup to write end	25	-	30	-	ns
t _{HD}	Data hold from write end	0	-	0	-	ns
t _{HZWE}	WE LOW to high-Z ^[14, 15]	-	20	-	25	ns
t _{LZWE}	WE HIGH to low-Z ^[14]	10	-	10	-	ns
	•					

<sup>Notes
13. Test conditions for all parameters other than Tri-state parameters assume signal transition time of 1 ns/V, timing reference levels of V_{CC(typ})/2, input pulse levels of 0 to V_{CC(typ}), and output loading of the specified I_{OL}/I_{OH} as shown in the "AC Test Loads and Waveforms" section.
14. At any temperature and voltage condition, t_{HZCE} is less than t_{LZCE}, t_{HZBE} is less than t_{LZDE}, t_{HZDE} is less than t_{LZDE}, and t_{HZWE} is less than t_{LZWE} for any device.
15. t_{HZOE}, t_{HZEE}, t_{HZEE}, t_{HZEE}, t_{HZEE}, t_{HZEE} the outputs enter a high impedance state.
16. The internal Write time of the memory is defined by the overlap of WE, CE₁ = V_{IL}, BHE and/or BLE = V_{IL}, and CE₂ = V_{IH}. All signals must be ACTIVE to initiate a write and any of these signals can terminate a write by going INACTIVE. The data input setup and hold timing should be referenced to the edge of the signal that terminates the Write.</sup>



Switching Waveforms

Figure 5. Read Cycle 1 (Address Transition Controlled) ^[17, 18]

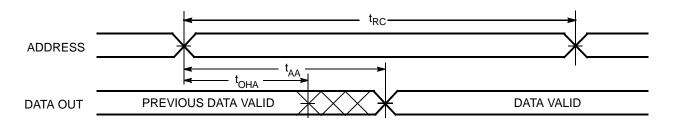
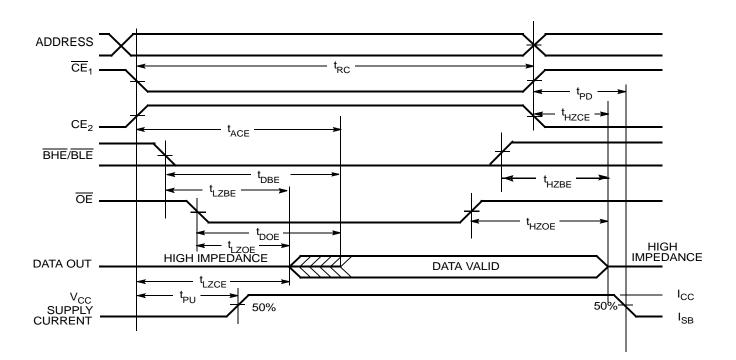


Figure 6. Read Cycle 2 (OE Controlled) ^[18, 19]



- 17. The device is continuously selected. \overline{OE} , $\overline{CE}_1 = V_{IL}$, \overline{BHE} and/or $\overline{BLE} = V_{IL}$, and $CE_2 = V_{IH}$. 18. \overline{WE} is HIGH for read cycle. 19. Address valid prior to or coincident with \overline{CE}_1 , \overline{BHE} , \overline{BLE} transition LOW and CE_2 transition HIGH.



Switching Waveforms (continued)

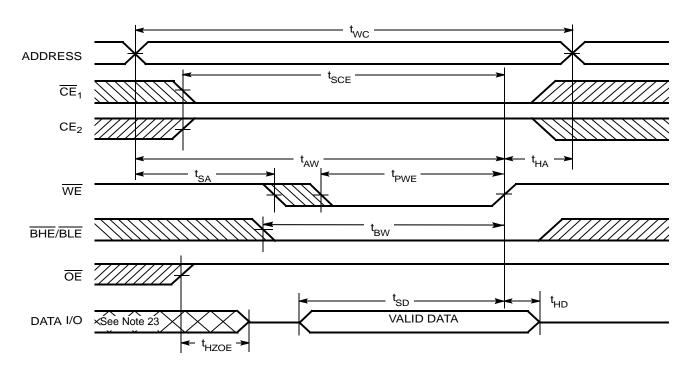
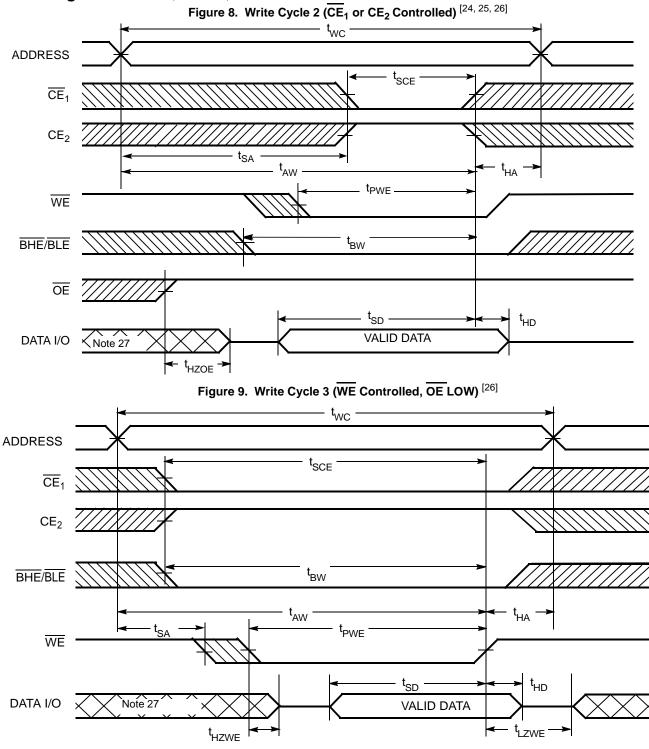


Figure 7. Write Cycle 1 (WE Controlled) ^[20, 21, 22]

- 20. The internal Write time of the memory is defined by the overlap of \overline{WE} , $\overline{CE}_1 = V_{IL}$, \overline{BHE} and/or $\overline{BLE} = V_{IL}$, and $CE_2 = V_{IH}$. All signals must be ACTIVE to initiate a write and any of these signals can terminate a write by going INACTIVE. The data input setup and hold timing should be referenced to the edge of the signal that terminates the Write.
- 21. Data I/O is high-impedance if $\overline{OE} = V_{\text{IH}}$. 22. If \overline{CE}_1 goes HIGH and CE_2 goes LOW simultaneously with $\overline{WE} = V_{\text{IH}}$, the output remains in a high-impedance state. 23. During this period, the I/Os are in output state and input signals should not be applied.



Switching Waveforms (continued)



- 24. The internal Write time of the memory is defined by the overlap of \overline{WE} , $\overline{CE}_1 = V_{IL}$, \overline{BHE} and/or $\overline{BLE} = V_{IL}$, and $CE_2 = V_{IH}$. All signals must be ACTIVE to initiate a write and any of these signals can terminate a write by going INACTIVE. The data input setup and hold timing should be referenced to the edge of the signal that terminates the Write.
- 25. Data I/O is high-impedance if $\overline{OE} = V_{IH}$. 26. If \overline{CE}_1 goes HIGH and CE_2 goes LOW simultaneously with $\overline{WE} = V_{IH}$, the output remains in a high-impedance state. 27. During this period, the I/Os are in output state and input signals should not be applied.



Switching Waveforms (continued)

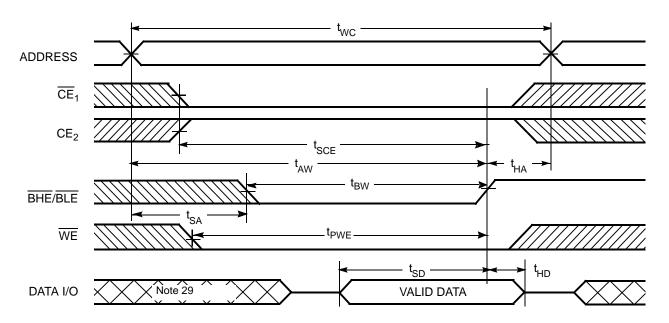


Figure 10. Write Cycle 4 (BHE/BLE Controlled, OE LOW) ^[28]

Notes ______ 28. If CE₁ goes HIGH and CE₂ goes LOW simultaneously with $\overline{WE} = V_{IH}$, the output remains in a high-impedance state. 29. During this period, the I/Os are in output state and input signals should not be applied.





Truth Table

CE ₁	CE ₂	WE	OE	BHE	BLE	Inputs/Outputs	Mode	Power
Н	Х	Х	Х	Х	Х	High Z	Deselect/Power-down	Standby (I _{SB})
Х	L	Х	Х	Х	Х	High Z	Deselect/Power-down	Standby (I _{SB})
Х	Х	Х	Х	Н	Н	High Z	Deselect/Power-down	Standby (I _{SB})
L	Н	Н	L	L	L	Data out (I/O ₀ –I/O ₁₅)	Read	Active (I _{CC})
L	Н	Η	L	Н	L	High Z (I/O ₈ –I/O ₁₅); Data out (I/O ₀ –I/O ₇)	Read	Active (I _{CC})
L	Н	Η	L	L	Н	Data out (I/O ₈ –I/O ₁₅); High Z (I/O ₀ –I/O ₇)	Read	Active (I _{CC})
L	Н	L	Х	L	L	Data in (I/O ₀ -I/O ₁₅)	Write	Active (I _{CC})
L	Н	L	Х	Н	L	High Z (I/O ₈ –I/O ₁₅); Data in (I/O ₀ –I/O ₇)	Write	Active (I _{CC})
L	Н	L	Х	L	Н	Data in (I/O ₈ –I/O ₁₅); High Z (I/O ₀ –I/O ₇)	Write	Active (I _{CC})
L	Н	Н	Н	L	Н	High Z	Output disabled	Active (I _{CC})
L	Н	Н	Н	Н	L	High Z	Output disabled	Active (I _{CC})
L	Н	Н	Н	L	L	High Z	Output disabled	Active (I _{CC})

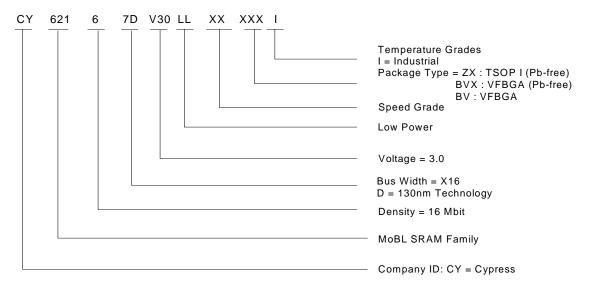


Ordering Information

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
55	CY62167DV30LL-55BVI	51-85178	48-ball FBGA (8 × 9.5 × 1 mm)	Industrial
	CY62167DV30LL-55BVXI		48-ball FBGA (8 × 9.5 × 1 mm) Pb-free	
	CY62167DV30LL-55ZXI	51-85183	48-pin TSOP I (12 × 18.4 × 1 mm) Pb-free	
70	CY62167DV30LL-70BVI	51-85178	48-ball FBGA (8 × 9.5 × 1 mm)	

Please contact your local Cypress sales representative for availability of these parts

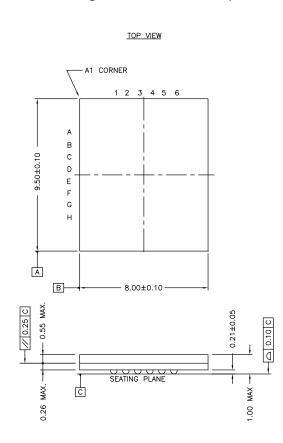
Ordering Code Definitions

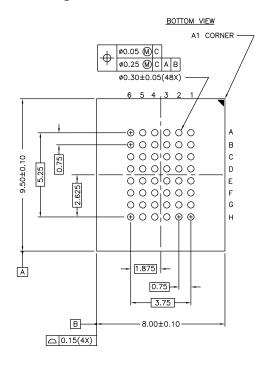




Package Diagrams

Figure 11. 48-ball VFBGA (8 × 9.5 × 1 mm) BV48B Package Outline, 51-85178





51-85178 *C

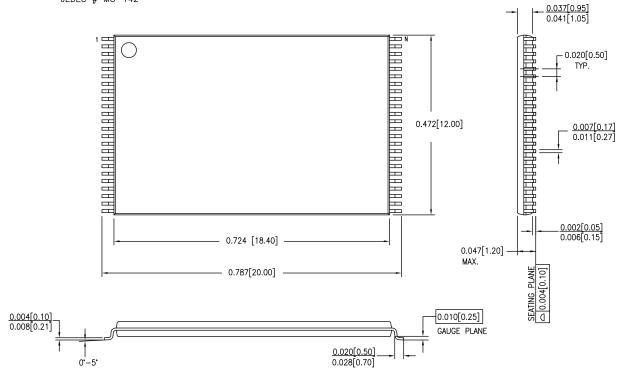




Package Diagrams (continued) Figure 12. 48-pin TSOP I (12 × 18.4 × 1 mm) Z48A Package Outline, 51-85183

DIMENSIONS IN INCHES[MM] MIN. MAX.

JEDEC # MO-142



51-85183 *C



Acronyms

Acronym	Description
CMOS	Complementary Metal Oxide Semiconductor
I/O	Input/Output
SRAM	Static Random Access Memory
TSOP	Thin Small Outline Package
VFBGA	Very Fine-Pitch Ball Grid Array

Document Conventions

Units of Measure

Symbol	Unit of Measure
°C	degrees Celsius
MHz	megahertz
μΑ	microampere
mA	milliampere
ns	nanosecond
Ω	ohm
pF	picofarad
V	volt
W	watt





Document History Page

Revision	ECN	Orig. of Change	Submission Date	Description of Change
**	118408	GUG	09/30/02	New data sheet.
*A	123692	DPM	02/11/03	Changed status from Advanced to Preliminary. Added package diagram
*B	126555	DPM	04/25/03	Minor change: Changed Sunset Owner from DPM to HRT
*C	127841	XRJ	09/10/03	Added 48 TSOP I package
*D	205701	AJU	See ECN	Changed BYTE pin usage description for 48 TSOPI package
*E	238050	KKV/AJU	See ECN	Replaced 48-ball VFBGA package diagram; Modified Package Name in Ordering Information table from BV48A to BV48B
*F	304054	PCI	See ECN	Added 45-ns Speed Bin in AC, DC and Ordering Information tables Added Footnote #12 on page #4 Added Pb-free packages on page # 10
*G	492895	VKN	See ECN	Modified datasheet to explain x8 configurability. Removed L power bin from the product offering Updated Ordering Information Table
*H	2896036	AJU	03/19/10	Removed 45-ns. Removed inactive parts from Ordering Information. Updated Packaging Information Updated links in Sales, Solutions, and Legal Information.
*	3067267	RAME	11/08/10	Updated datasheet as per new template Added Ordering Code Definitions. Added Acronyms and Units of Measure. Updated all table notes to footnote. Package diagram updated 51-85178 from ** to *A
*J	3329789	RAME	07/27/11	Removed references to AN1064 SRAM system guidelines. Updated template according to current CY standards.
*К	4108382	AJU	08/29/2013	Updated Pin Configurations: Removed the note "Ball H6 for the FBGA package can be used to upgrade to a 32M density" and its reference in <i>Figure 1</i> . Updated Package Diagrams: spec 51-85178 – Changed revision from *A to *C.
				Updated in new template.



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